# Power MOSFET 45 Amps, 60 Volts

# N-Channel TO-220 and D2PAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

#### **Features**

- Higher Current Rating
- Lower R<sub>DS(on)</sub>
- Lower V<sub>DS(on)</sub>
- Lower Capacitances
- Lower Total Gate Charge
- Tighter V<sub>SD</sub> Specification
- Lower Diode Reverse Recovery Time
- Lower Reverse Recovery Stored Charge

## **Typical Applications**

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

### **MAXIMUM RATINGS** (T<sub>.J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	60	Vdc
Drain-to-Gate Voltage ( $R_{GS} = 10 \text{ M}\Omega$ )	VDGR	60	Vdc
Gate-to-Source Voltage			Vdc
<ul><li>Continuous</li></ul>	VGS	±20	
<ul><li>Non–Repetitive (t<sub>p</sub>≤10 ms)</li></ul>	VGS	±30	
Drain Current			
– Continuous @ T <sub>A</sub> = 25°C	ΙD	45	Adc
– Continuous @ T <sub>A</sub> = 100°C	ΙD	30	
<ul><li>Single Pulse (t<sub>p</sub> ≤ 10 μs)</li></ul>	IDM	150	Apk
Total Power Dissipation @ T <sub>A</sub> = 25°C	$P_{D}$	125	W
Derate above 25°C		0.83	W/°C
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 1.)		3.2	W
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 2.)		2.4	W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to	°C
		+175	
Single Pulse Drain-to-Source Avalanche	EAS	240	mJ
Energy – Starting T <sub>J</sub> = 25°C			
$(V_{DD} = 50 \text{ Vdc}, V_{GS} = 10 \text{ Vdc}, RG = 25 \Omega,$			
$I_{L(pk)} = 40 \text{ A}, L = 0.3 \text{ mH}, V_{DS} = 60 \text{ Vdc}$			

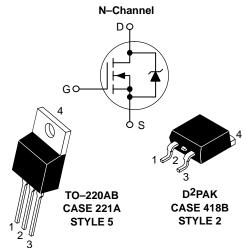
- When surface mounted to an FR4 board using 1" pad size, (Cu Area 1.127 in<sup>2</sup>).
- When surface mounted to an FR4 board using the minimum recommended pad size, (Cu Area 0.412 in<sup>2</sup>).



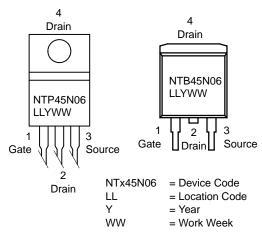
# ON Semiconductor™

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# 45 AMPERES 60 VOLTS RDS(on) = 26 m $\Omega$



# MARKING DIAGRAMS & PIN ASSIGNMENTS



#### **ORDERING INFORMATION**

Device	Package	Shipping
NTP45N06	TO-220AB	50 Units/Rail
NTB45N06	D <sup>2</sup> PAK	50 Units/Rail
NTB45N06T4	D <sup>2</sup> PAK	800/Tape & Reel

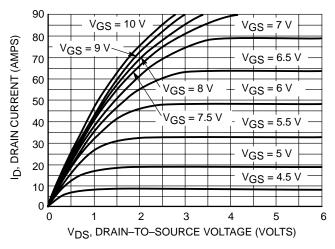
# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Thermal Resistance – Junction–to–Case – Junction–to–Ambient (Note 3.) – Junction–to–Ambient (Note 4.)	R <sub>θ</sub> JC R <sub>θ</sub> JA R <sub>θ</sub> JA	1.2 46.8 63.2	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

## **ELECTRICAL CHARACTERISTICS** (T<sub>.J</sub> = 25°C unless otherwise noted)

DFF CHARACTERISTICS           Drain-to-Source Breakdown Voltage (Note 5.)         V(BR)DSS         60         70         -           (VGS = 0 Vdc, ID = 250 μAdc)         -         57         -         mV/°C           Zero Gate Voltage Drain Current         IDSS         -         -         1.0         μAdc           (VDS = 60 Vdc, VGS = 0 Vdc)         -         -         10         -         10         -           Gate-Body Leakage Current (VGS = ±20 Vdc, VDS = 0 Vdc)         IGSS         -         -         ±100         nAdc           ON CHARACTERISTICS (Note 5.)         VGS(th)         2.0         2.8         4.0         mV/°C           Gate Threshold Voltage (Note 5.)         VGS(th)         2.0         2.8         4.0         mV/°C           Threshold Temperature Coefficient (Negative)         RDS(on)         -         7.2         -         mOhm           (VGS = 10 Vdc, ID = 22.5 Adc)         VDS(on)         -         21         26         Vdc           Static Drain-to-Source On-Voltage (Note 5.)         VDS(on)         -         0.93         1.4           (VGS = 10 Vdc, ID = 45 Adc)         -         0.93         -         -           (VGS = 10 Vdc, ID = 22.5 Adc, TJ = 150°C)         -	CI	Symbol	Min	Тур	Max	Unit	
Drain-to-Source Breakdown Voltage (Note 5.)	OFF CHARACTERISTICS		<u>-</u>	I	1	I	I
(VDS = 60 Vdc, VGS = 0 Vdc), VDS = 0 Vdc, TJ = 150°C)         1.0         1.0         1.0           Gate-Body Leakage Current (VGS = ±20 Vdc, VDS = 0 Vdc)         IGSS         ±100         nAdc           ON CHARACTERISTICS (Note 5.)         VGS(th)         2.0         2.8         4.0         MVCC           Threshold Voltage (Note 5.)         VGS(th)         2.0         2.8         4.0         MVCC           Threshold Temperature Coefficient (Negative)         - 7.2 <td< td=""><td><math>(V_{GS} = 0 \text{ Vdc}, I_{D} = 250 \mu \text{Add})</math></td><td>V(BR)DSS</td><td></td><td>_</td><td>_ _</td><td>Vdc mV/°C</td></td<>	$(V_{GS} = 0 \text{ Vdc}, I_{D} = 250 \mu \text{Add})$	V(BR)DSS		_	_ _	Vdc mV/°C	
Concentration   Characteristics   Concentration   Concentra	$(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$	:)	IDSS	_ _	- -		μAdc
Gate Threshold Voltage (Note 5.) (Vps = Vgs, lp = 250 μAdc) (Vps = Vgs, lp = 250 μAdc) Threshold Temperature Coefficient (Negative)   2.0	Gate-Body Leakage Current (V	$V_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc}$	IGSS	_	_	±100	nAdc
(Vps = Vgs, lp = 250 μAdc)	ON CHARACTERISTICS (Note 5	5.)					
VGS = 10 Vdc, ID = 22.5 Adc)	$(V_{DS} = V_{GS}, I_{D} = 250 \mu Adc)$		VGS(th)	2.0			Vdc mV/°C
		,	R <sub>DS(on)</sub>	-	21	26	mOhm
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	(VGS = 10 Vdc, ID = 45 Adc)	V <sub>DS(on)</sub>	_ _			Vdc	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance (No	9FS	_	16.6	_	mhos	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	DYNAMIC CHARACTERISTICS						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance		C <sub>iss</sub>	-	1224	1725	pF
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance		C <sub>oss</sub>	-	345	485	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Transfer Capacitance	- ,	C <sub>rss</sub>	_	76	160	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	SWITCHING CHARACTERISTIC	<b>S</b> (Note 6.)		-			-
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time		<sup>t</sup> d(on)	_	10	25	ns
	Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_{D} = 45 \text{ Adc},$	t <sub>r</sub>	-	101	200	
	Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc}, R_{G} = 9.1 \Omega) \text{ (Note 5.)}$	t <sub>d</sub> (off)	-	33	70	
	Fall Time		t <sub>f</sub>	-	106	220	
$V_{GS} = 10 \text{ Vdc}) \text{ (Note 5.)} \qquad \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Gate Charge		Q <sub>T</sub>	-	33	46	nC
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			Q <sub>1</sub>	-	6.4	_	1
Forward On–Voltage		163 = 10 146) (166 6.)	Q <sub>2</sub>	-	15	-	
	SOURCE-DRAIN DIODE CHAR	ACTERISTICS		•	•		•
$(I_S = 45 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s}) \text{ (Note 5.)}$ $t_a - 36 - \\ t_b - 16.9 -$	Forward On-Voltage		V <sub>SD</sub>				Vdc
$\frac{dI_{S}/dt = 100 \text{ A/µs) (Note 5.)}}{t_{b}} = \frac{t_{a}}{t_{b}} = \frac{30}{t_{b}} = \frac{-16.9}{t_{b}}$	Reverse Recovery Time		t <sub>rr</sub>	_	53.1	_	ns
t <sub>b</sub> – 16.9 –			ta	-	36	-	
Reverse Recovery Stored Charge Q <sub>RR</sub> - 0.087 - μC			t <sub>b</sub>	-	16.9	-	]
	Reverse Recovery Stored Char	ge	Q <sub>RR</sub>	_	0.087	-	μС

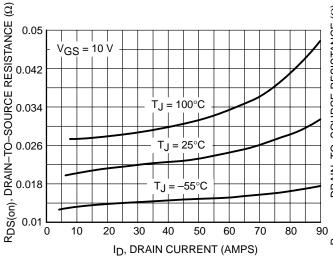
- 3. When surface mounted to an FR4 board using 1" pad size, (Cu Area 1.127 in $^2$ ).
- 4. When surface mounted to an FR4 board using the minimum recommended pad size, (Cu Area 0.412 in<sup>2</sup>).
- 5. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
- 6. Switching characteristics are independent of operating junction temperatures.



 $V_{DS} > = 10 \text{ V}$ 80 ID, DRAIN CURRENT (AMPS) 70 60 50 40 30  $T_{.1} = 25^{\circ}C_{.1}$ 20  $T_{.1} = 100^{\circ}C$ 10  $T_{.1} = -55^{\circ}C$ 0 5.5 6 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



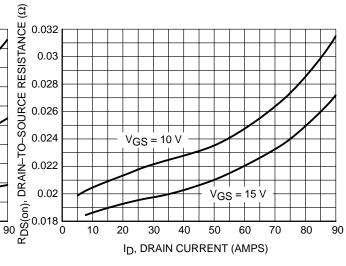
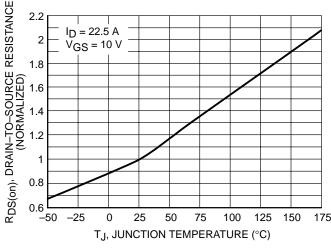


Figure 3. On–Resistance vs. Gate–to–Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



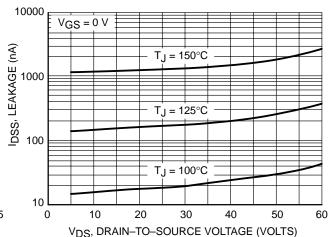


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

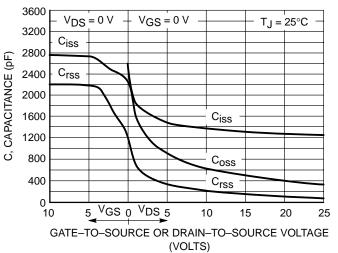


Figure 7. Capacitance Variation

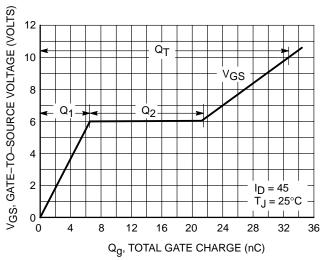


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

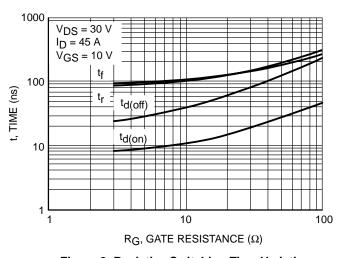


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

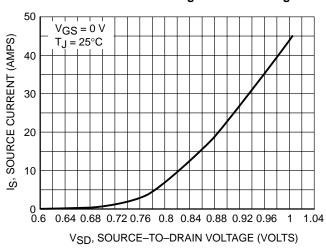


Figure 10. Diode Forward Voltage vs. Current

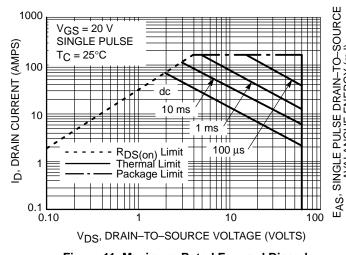


Figure 11. Maximum Rated Forward Biased Safe Operating Area

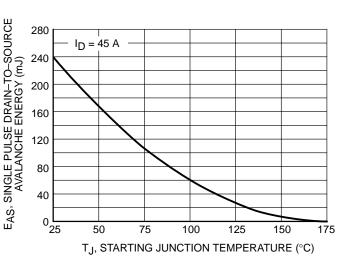


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

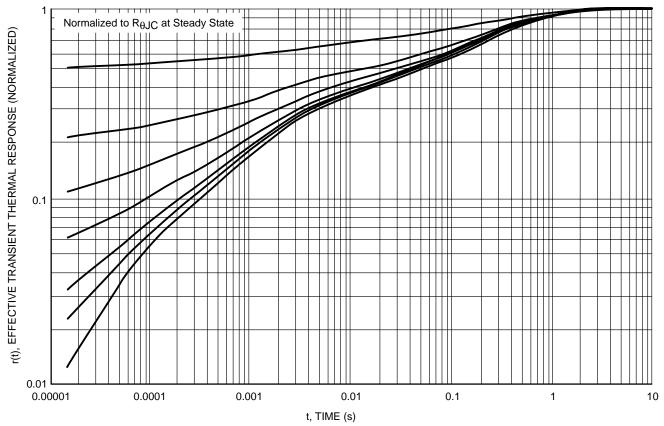


Figure 13. Thermal Response

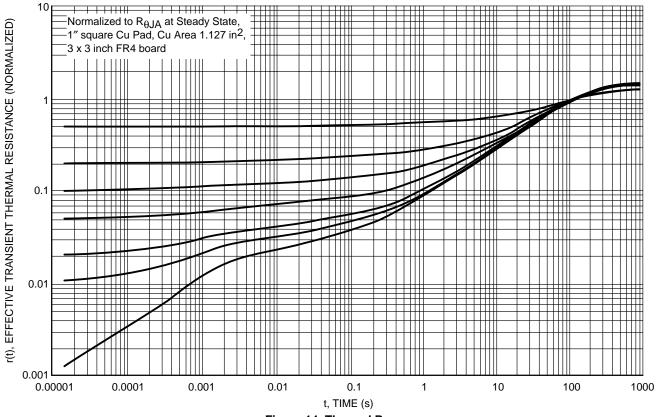
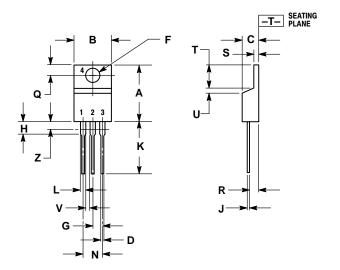


Figure 14. Thermal Response

# **PACKAGE DIMENSIONS**

# **TO-220 THREE-LEAD** TO-220AB

CASE 221A-09 **ISSUE AA** 



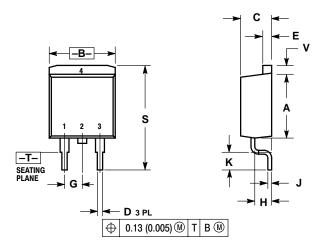
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN MAX	
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
H	0.110	0.155	2.80	3.93
7	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Ø	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
5	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

- STYLE 5:
  PIN 1. GATE
  2. DRAIN
  3. SOURCE
  4. DRAIN

# **PACKAGE DIMENSIONS**

D<sup>2</sup>PAK CASE 418B-03 ISSUE D



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN MAX	
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
Е	0.045	0.055	1.14	1.40
G	0.100 BSC		2.54 BSC	
Н	0.080	0.110	2.03	2.79
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
S	0.575	0.625	14.60	15.88
٧	0.045	0.055	1.14	1.40

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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